Applicant(s)/Patent Under Reexamination 10/542,614 HIWATA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Theresa Trieu 3748

Application/Control No.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,627,800	12-1986	Matsudaira et al.	418/55.2
*	В	US-6,244,840	06-2001	Takeuchi et al.	418/55.2
*	С	US-6,478,557	11-2002	Shiibayashi et al.	418/55.2
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ł	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000283065 A	10-2000	Japan	SATO et al.	F04C 18/02
	0	JP 2000329079 A	11-2000	Japan	ARATA, TETSUYA	F04C 18/02
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.